

**Notice of References Cited**Application/Control No.  
09/400,346Applicant(s)/Patent Under  
Reexamination  
TOYAMA ET AL.Examiner  
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2623

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,335,985	01-2002	Sambonsugi et al.	382/190
	B	US-6,263,091	07-2001	Jain et al.	382/124
	C	US-6,400,374	06-2002	Lanier, Jaron	345/630
	D	US-5,787,199	07-1998	Lee, Min-Sup	348/415.1
	E	US-6,301,385	10-2001	Chen et al.	382/173
	F	US-6,288,703	09-2001	Berman et al.	345/421
	G	US-5,566,251	10-1996	Hanna et al.	348/588
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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